



# TECHNICAL REPORT

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**Metallic communication cable test methods –  
Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic  
(EMC) screening measurements**

Withhold

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

PRICE CODE

**XA**

## CONTENTS

FOREWORD.....	5
INTRODUCTION.....	7
1 Scope.....	8
2 Normative references.....	8
3 List of symbols.....	9
4 Electromagnetic phenomena.....	10
5 Intrinsic screening parameters of short cables.....	12
5.1 Surface transfer impedance, $Z_T$ .....	12
5.2 Capacitive coupling admittance, $Y_C$ .....	12
5.3 Injecting with arbitrary cross-sections.....	14
5.4 Reciprocity and symmetry.....	14
5.5 Arbitrary load conditions.....	14
6 Long cables – Coupled transmission lines.....	14
7 Transfer impedance of a braided-wire outer conductor or screen.....	20
8 Test possibilities.....	26
8.1 Measuring the transfer impedance of coaxial cables.....	26
8.2 Measuring the transfer impedance of cable assemblies.....	27
8.3 Measuring the transfer impedance of connectors.....	27
8.4 Calculated maximum screening level.....	27
9 Comparison of frequency response of different triaxial test set-ups to measure transfer impedance of cable screens.....	32
9.1 Introductory remark.....	32
9.2 Physical basics.....	32
9.3 Simulations.....	35
9.4 Conclusion.....	49
Bibliography.....	50
Additional reading.....	51
Figure 1 – Incident (i), scattered (s) and resulting total electromagnetic fields ( $E_t, H_t$ ) with induced surface current- and charge- densities $J$ (A/m) and $\sigma$ (C/m <sup>2</sup> ).....	11
Figure 2 – Defining and measuring screening parameters – Triaxial set-up.....	11
Figure 3a – Equivalent circuit for the definition and possible testing of $Z$ .....	13
Figure 3b – Equivalent circuit for the definition and possible testing of $Y_C = j \omega C_T$ .....	13
Figure 3c – Definition of electrical quantities in a set-up that is matched at all ends.....	13
Figure 3 – Defining and measuring screen parameters – Equivalent circuits.....	13
Figure 4 – Summing function $S\{l \cdot f\}$ for near (n) and far (f) end coupling.....	17
Figure 5a – Transfer impedance of a typical single braid screen.....	18
Figure 5b – Coupling transfer function for the same cable with negligible $Z_F$ ( $Z_F \ll Z_T$ ): frequency responses of Figure 4 and Figure 5a added on log scale.....	18
Figure 5 – The effect of the summing function.....	18

Figure 6 – The effects of the $Z_T$ and $Z_F$ to the coupling transfer functions $T_n$ and $T_f$ .....	19
Figure 7 – $l \times S$ : complete length dependent factor in the coupling function $T$ (see Table 1) .....	20
Figure 8 – Transfer impedance of typical cables .....	21
Figure 9a – Complete flux .....	21
Figure 9b – Left-hand lay contribution .....	21
Figure 9c – Right-hand lay contribution .....	21
Figure 9 – Magnetic coupling in the braid .....	21
Figure 10a – Complex plane, $Z_T = Re Z_T + j Im Z_T$ , frequency $f$ as parameter .....	22
Figure 10b – Magnitude (amplitude), $ Z_T(f) $ .....	23
Figure 10 – Measured transfer impedance $Z_T$ (d.c. resistance $Z_T$ (d.c.) set to the value of 10 m $\Omega$ /m .....	23
Figure 11a – Overbraided cable .....	24
Figure 11b – Underbraided cable .....	24
Figure 11 – Typical $Z_T$ (time) step response of an overbraided and underbraided single braided outer conductor of a coaxial cable .....	24
Figure 12a – Contributions to the transfer impedance .....	25
Figure 12b – Significant elements of circuits (1) and (2) .....	25
Figure 12 – $Z_T$ equivalent circuits of a braided-wire screen .....	25
Figure 13 – Example of visualization of the maximum measurable screening level .....	28
Figure 14 – Triaxial set-up for the measurement of the transfer impedance $Z_T$ .....	32
Figure 15 – Equivalent circuit of the triaxial set-up .....	32
Figure 16 – Simulation of frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 2,3$ (solid PE), $\epsilon_{r2} = 1,0$ , $n = 0,659$ .....	37
Figure 17 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 1,6$ (foam PE), $\epsilon_{r2} = 1,0$ , $n = 0,791$ .....	37
Figure 18 – Simulation of frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 1,3$ (foam PE), $\epsilon_{r2} = 1,0$ , $n = 0,877$ .....	38
Figure 19 – Simulation of frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 5$ (PVC), $\epsilon_{r2} = 1,0$ , $n = 0,447$ .....	38
Figure 20 – Simulation of the 3 dB cut off wavelength ( $L/\lambda_1$ ) as a function of factor $n = \sqrt{\epsilon_{r2}}/\sqrt{\epsilon_{r1}}$ given for different factors $v = Z_2/R_{2,f}$ .....	39
Figure 21 – Interpolation of the simulated 3 dB cut off wavelength ( $L/\lambda_1$ ) as a function of factor $n = \sqrt{\epsilon_{r2}}/\sqrt{\epsilon_{r1}}$ given for different factors $v = Z_2/R_{2,f}$ .....	39
Figure 22 – 3 dB cut-off frequency length product as a function of dielectric permittivity of the inner circuit (cable) given for different factors $v = Z_2/R_{2,f}$ .....	40
Figure 23 – Measurement result of the normalized voltage drop of a single braid screen in the triaxial set-up for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 2,3$ (PE), $\epsilon_{r2} = 1,0$ , $n = 0,659$ , $Z_2 = 130 \Omega$ , $L = 1$ m .....	41
Figure 24 – Measurement result of the normalized voltage drop of a single braid screen in the triaxial set-up for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 1,6$ (foam PE), $\epsilon_{r2} = 1,0$ , $n = 0,791$ , $Z_2 = 130 \Omega$ , $L = 1$ m .....	41
Figure 25 – Triaxial set-up (measuring tube), double short-circuited method .....	42
Figure 26 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 2,3$ (solid PE), $\epsilon_{r2} = 1,0$ , $n = 0,659$ .....	43
Figure 27 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 1,6$ (foam PE), $\epsilon_{r2} = 1,0$ , $n = 0,791$ .....	43

Figure 28 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 1,3$ (foam PE), $\epsilon_{r2} = 1,0$ , $n = 0,877$ .....	44
Figure 29 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 5$ (PVC), $\epsilon_{r2} = 1,0$ , $n = 0,447$ .....	44
Figure 30 – Interpolation of the simulated 3 dB cut-off wavelength ( $L/\lambda_1$ ) as a function of factor $n = \sqrt{\epsilon_{r2}}/\sqrt{\epsilon_{r1}}$ given for different factors $v = Z_2/R_{2,f}$ .....	45
Figure 31 – 3 dB cut-off frequency length product as a function of dielectric permittivity of the inner circuit (cable) given for different factors $v = Z_2/R_{2,f}$ .....	46
Figure 32 – Simulation of the frequency response for different factors of $v = Z_2/R_{2,f}$ with $\epsilon_{r1} = 2,3$ (PE), $\epsilon_{r2} = 5$ (PVC), $n = 1,474$ .....	47
Figure 33 – Interpolation of the simulated 3 dB cut off wavelength ( $L/\lambda_1$ ) as a function of factor $n = \sqrt{\epsilon_{r2}}/\sqrt{\epsilon_{r1}}$ given for $v = Z_2/R_{2,f} \ll 1$ .....	48
Figure 34 – 3 dB cut-off frequency length product as a function of the dielectric permittivity of the inner circuit (cable) given for different factors $n = \sqrt{\epsilon_{r2}}/\sqrt{\epsilon_{r1}}$ , $v = Z_2/R_{2,f} \ll 1$ .....	48
Table 1 – The coupling transfer function $T$ (coupling function) .....	16
Table 2 – Screening effectiveness of cable test methods for surface transfer impedance $Z_T$ ..	30
Table 3 – Load conditions of the different set-ups .....	34
Table 4 – Parameters of the different set-ups .....	36
Table 5 – Cut-off frequency length product .....	40
Table 6 – Typical values for factor $v$ , for an inner tube diameter of 40 mm and a generator output impedance of 50 $\Omega$ .....	42
Table 7 – Cut-off frequency length product .....	45
Table 8 – Material combinations and factor $n$ .....	47
Table 9 – Cut-off frequency length product for some typical cables in the different set-ups .....	49

## INTERNATIONAL ELECTROTECHNICAL COMMISSION

### METALLIC COMMUNICATION CABLE TEST METHODS –

#### Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic (EMC) screening measurements

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IEC/TR 62153-4-1, which is a technical report, has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This publication cancels and replaces IEC/TR 61917, published in 1998.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
46/199/DTR	46/253/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

Withdrawn

## INTRODUCTION

Screening is one basic way of achieving electromagnetic compatibility (EMC). However, a confusingly large number of methods and concepts is available to test for the screening quality of cables and related components, and for defining their quality.

IEC/TR 62153-4-1 provides a brief introduction to basic concepts and terms trying to reveal the common features of apparently different test methods. It should assist in correct interpretation of test data, and in the better understanding of screening (or shielding) and related specifications and standards.

Withdrawn

## METALLIC COMMUNICATION CABLE TEST METHODS –

### Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic (EMC) screening measurements

#### 1 Scope

IEC/TR 62153-4-1, which is a technical report, gives a brief introduction to basic concepts and terms that reveal the common features of various test methods.

#### 2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60096-4-1:1990, *Radio-frequency cables – Part 4: Specification for superscreened cables – Section 1: General requirements and test methods*

IEC 60169-1-3:1988, *Radio frequency connectors – Part 1: General requirements and measuring methods – Section 3: Electrical tests and measuring procedures – Screening effectiveness*

IEC 61196-1:2005, *Coaxial communication cables – Part 1: Generic specification – General, definitions and requirements – Second edition*

IEC 61726: *Cable assemblies, cables, connectors and passive microwave components – Screening attenuation measurement by the reverberation chamber method*

IEC 62153-4-2, *Metallic communication cables test methods – Part 4-2: Electromagnetic compatibility (EMC) – Screening and coupling attenuation – Injection clamp method*

IEC 62153-4-3, *Metallic communication cables test methods – Part 4-3: Electromagnetic compatibility (EMC) – Surface transfer impedance – Triaxial method*

IEC 62153-4-5, *Metallic communication cables test methods – Part 4-5: Electromagnetic compatibility (EMC) – Coupling or screening attenuation – Absorbing clamp method*

IEC 62153-4-7, *Metallic communication cables test methods – Part 4-7: Electromagnetic compatibility (EMC) – Test method for measuring the transfer impedance and the screening – or the coupling attenuation – Tube in tube method*

IEC 62153-4-9, *Metallic communication cable test methods – Part 4-9: Electromagnetic Compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method<sup>1</sup>*

EN 50289-1-6, *Communication cables – Specification for test methods – Electrical test methods – Electromagnetic performance*

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<sup>1</sup> To be published.